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| Notice of References Cited | Application/Control No. 10/661,454 | Applicant(s)/Patent Under Reexamination PHAN, HUY D. | |
| | Examiner John P. Leubecker | Art Unit 3739 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| | A | US-4,911,147 | 03-1990 | Washizuka, Nobuhiko | 600/161 |
| | B | US-5,607,386 | 03-1997 | Flam, Gary H. | 600/120 |
| | C | US-5,327,881 | 07-1994 | Greene, Christopher M. | 600/120 |
| | D | US-4,741,326 | 05-1988 | Sidall et al. | 600/123 |
| | E | US-6,221,007 | 04-2001 | Green, Philip S. | 600/160 |
| | F | US-5,842,973 | 12-1998 | Bullard, James Roger | 600/194 |
| | G | US-6,527,761 | 03-2003 | Soltesz et al. | 604/516 |
| | H | US-6,694,979 | 02-2004 | Deem et al. | 128/207.14 |
| | I | US-2002/0010385 | 01-2002 | Ishibiki, Kouta | 600/139 |
| | J | US-4,601,284 | 07-1986 | Arakawa et al. | 600/112 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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